Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,792	NAKAMURA ET AL.	
Examiner	Art Unit	
Ha T. Nguyen	2812	

SEARCHED						
Subclass	Date	Examiner				

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
search	12/26/2005	HN			
printout					
	Subclass	Subclass Date search 12/26/2005			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST search (see printout)	12/26/2005	HN		